

**Rochester Electronics
Manufactured Components**

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceed the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
 - Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

SN54LS322A, SN74LS322A 8-BIT SHIFT REGISTERS WITH SIGN EXTEND

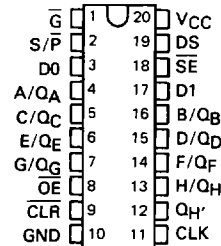
D2411, OCTOBER 1977 — REVISED MARCH 1988

- Multiplexed Inputs/Outputs Provide Improved Bit Density
- 3-State Outputs Drive Bus Lines Directly
- Sign Extend Function
- Direct Overriding Clear

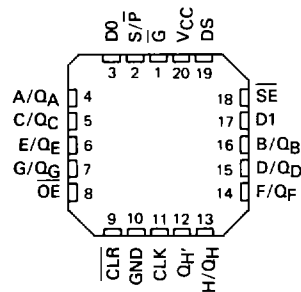
description

These low-power Schottky eight-bit shift registers feature multiplexed input/output data ports to achieve full eight-bit data handling in a single 20-pin package. Serial data may be entered into the shift-right register through either the D0 or the D1 input as selected by the data select input. A serial output (QH) is also provided to facilitate expansion. Synchronous parallel loading is accomplished by taking both the register enable and the S/P inputs low. This places the three-state input/output ports in the data input mode. Data are entered on the low-to-high transition of the clock. The data extend function repeats the sign in the QA flip-flop during shifting. A direct overriding clear input clears the internal registers when taken low whether the outputs are enabled or off. The output enable does not interfere with synchronous operation of the register.

SN54LS322A . . . J OR W PACKAGE
SN74LS322A . . . DW OR N PACKAGE
(TOP VIEW)



SN54LS322A . . . FK PACKAGE
(TOP VIEW)



FUNCTION TABLE

OPERATION	INPUTS							INPUTS/OUTPUTS				OUTPUT Q _H
	CLR	REGISTER ENABLE G	S/ $\overline{P}$	SIGN EXTEND SE	DATA SELECT DS	OUTPUT ENABLE OE	CLK	A/Q _A	B/Q _B	C/Q _C . . . H/Q _H		
Clear	L	H	X	X	X	L	X	L	L	L	L	L
	L	X	H	X	X	L	X	L	L	L	L	L
Hold	H	H	X	X	X	L	X	Q _{A0}	Q _{B0}	Q _{C0}	Q _{H0}	Q _{H0}
Shift Right	H	L	H	H	L	L	↑	D0	Q _{An}	Q _{Bn}	Q _{Gn}	Q _{Gn}
	H	L	H	H	H	L	↑	D1	Q _{An}	Q _{Bn}	Q _{Gn}	Q _{Gn}
Sign Extend	H	L	H	L	X	L	↑	Q _{An}	Q _{An}	Q _{Bn}	Q _{Gn}	Q _{Gn}
Load	H	L	L	X	X	X	↑	a	b	c	h	h
When the output enable is high, the eight input/output terminals are disabled to the high-impedance state, however, sequential operation or clearing of the register is not affected. If both the register enable input and the S/ $\overline{P}$ input are low while the clear input is low, the register is cleared while the eight input/output terminals are disabled to the high-impedance state.												

H = high level (steady state)

L = low level (steady state)

X = irrelevant (any input, including transitions)

↑ = transition from low to high level

QA0 . . . QH0 = the level of QA through QH, respectively, before the indicated steady-state conditions were established

QA_n . . . QH_n = the level of QA through QH, respectively, before the most recent ↑ transition of the clock

D0, D1 = the level of steady-state inputs at inputs D0 and D1 respectively

a . . . h = the level of steady-state inputs at inputs A through H respectively

PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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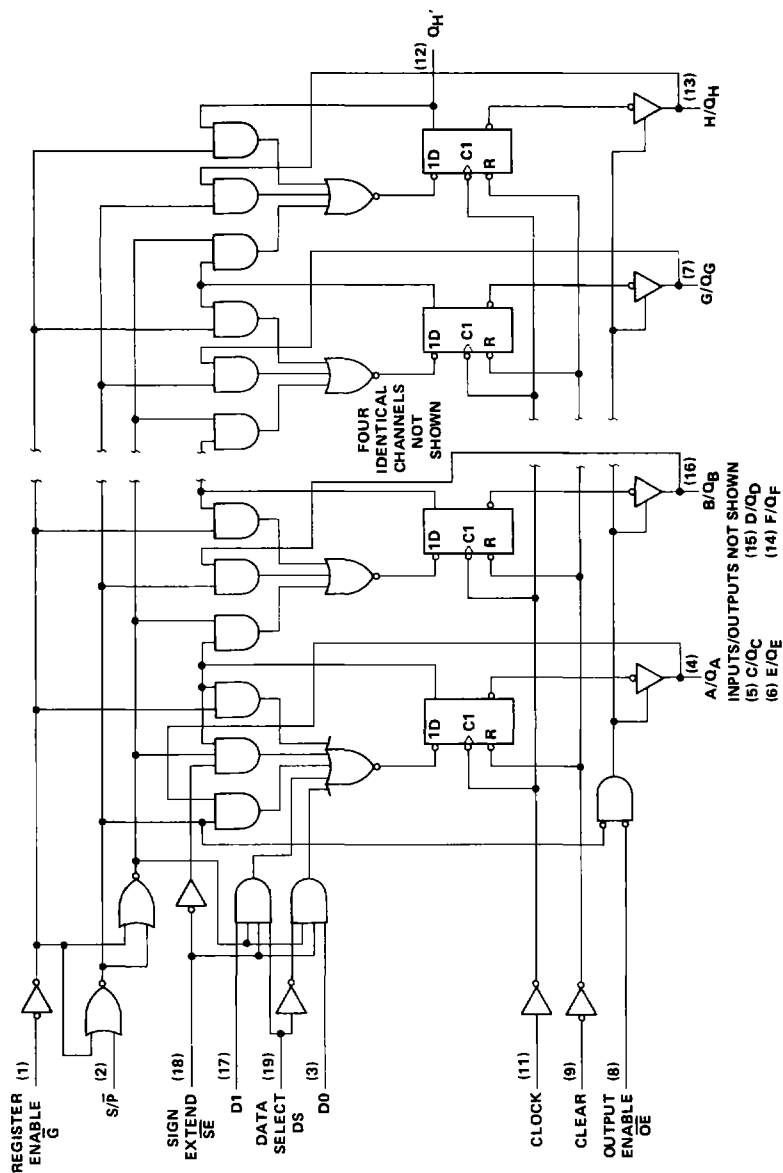
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SN54LS322A, SN74LS322A 8-BIT SHIFT REGISTERS WITH SIGN EXTEND

logic diagram (positive logic)

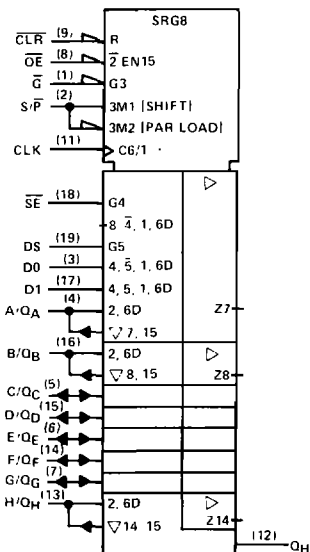
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Pin numbers shown are for DW, J, N, and W packages.

SN54LS322A, SN74LS322A 8-BIT SHIFT REGISTERS WITH SIGN EXTEND

logic symbol†

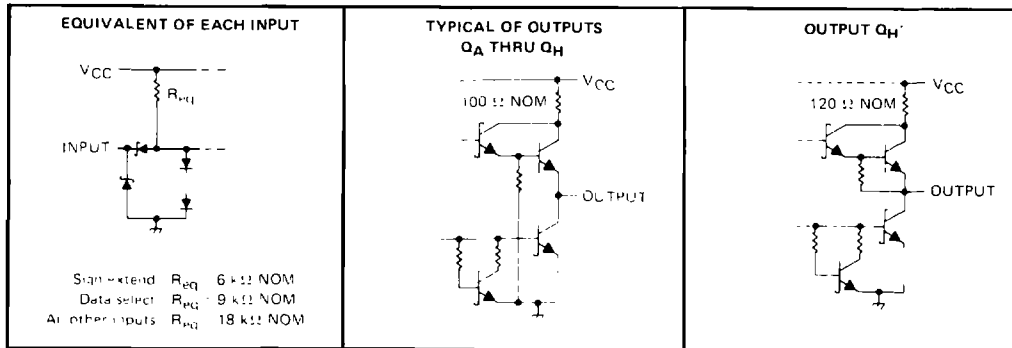


†This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617 12. Pin numbers shown are for DW, J, N, and W packages.

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schematics of inputs and outputs



SN54LS322A, SN74LS322A

8-BIT SHIFT REGISTERS WITH SIGN EXTEND

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage	7 V
Off-state output voltage	7 V
Operating free-air temperature range: SN54LS322A	–55°C to 125°C
SN74LS322A	0°C to 70°C
Storage temperature	–65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal

recommended operating conditions

			SN54LS322A			SN74LS322A			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
V _{IH}	High-level input voltage		2			2			V
V _{IL}	Low-level input voltage				0.7			0.5	V
I _{OH}	High-level output current	Q _A thru Q _H			−1			−2.6	mA
		Q _H '			−0.4			−0.4	
I _{OL}	Low-level output current	Q _A thru Q _H			12			24	mA
		Q _H '			4			8	
f _{clock}	Clock frequency		0		20	0		20	MHz
t _{w(clock)}	Width of clock pulse	Clock high	30			30			ns
		Clock low	10			10			
t _{w(clear)}		Clear low	20			20			ns
t _{su}	Setup time	Data select	10†			10†			ns
		High-level data †	20†			20†			
		Low-level data †	20†			20†			
		Clear inactive state	20†			20†			
		Register enable $\overline{G}$ high	35†			35†			
t _h	Hold time	Register enable $\overline{G}$ low	50†			50†			ns
		Data select	10†			10†			
		Data †	2†			2†			
T _A	Operating free-air temperature	Register enable high or low	0†			0†			°C
			−55		125	0		70	

†Data includes the two serial inputs and the eight input/output data lines.

†The arrow indicates that the rising edge of the clock pulse is used for reference.

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SN54LS322A, SN74LS322A 8-BIT SHIFT REGISTERS WITH SIGN EXTEND

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†			SN54LS322A		SN74LS322A		UNIT	
					MIN	TYP‡	MAX	MIN		TYP‡
V _{IK}		V _{CC} = MIN, I _I = - 18 mA			- 1.5		- 1.5		V	
V _{OH}	Q _A thru Q _H	V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = MAX.			2.4	3.2	2.4	3.1	V	
	Q _H '	I _{OH} = MAX			2.5	3.4	2.7	3.4		
V _{OL}	Q _A thru Q _H	V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = MAX	I _{OL} = 12 mA		0.25		0.4		V	
	I _{OL} = 24 mA				0.35		0.5			
	I _{OL} = 4 mA		0.25		0.4		0.25	0.4		
	I _{OL} = 8 mA						0.35	0.5		
I _{OZH}	Q _A thru Q _H	V _{CC} = MAX, V _{IH} = 2 V, V _O = 2.7 V			40		40		μA	
I _{OZL}	Q _A thru Q _H	V _{CC} = MAX, V _{IH} = 2 V, V _O = 0.4 V			- 0.4		- 0.4		mA	
I _I	A thru H	V _{CC} = MAX	V _I = 5.5 V		0.1		0.1		mA	
	V _I = 7 V		0.2		0.2					
	V _I = 7 V		0.3		0.3					
	V _I = 7 V		0.1		0.1					
			40		40					
I _{IH}	Sign extend	V _{CC} = MAX, V _I = 2.7 V			60		60		μA	
	Any other		20		20					
I _{IL}	Data select	V _{CC} = MAX, V _I = 0.4 V			- 0.8		- 0.8		mA	
	Sign extend		- 1.2		- 1.2					
	Any other		- 0.4		- 0.4					
I _{OS} §	Q _A thru Q _H	V _{CC} = MAX, V _O = 2.25 V (for 54LS only)	- 15		- 65		- 30 - 130		mA	
	Q _H '		- 10		- 50 - 20		- 100			
I _{CC}		V _{CC} = MAX			35		60		mA	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V_{CC} = 5 V, T_A = 25° C.

§ Not more than one output should be shorted at a time and duration of the short-circuit should not exceed one second.

switching characteristics, V_{CC} = 5 V, T_A = 25° C

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{max}			See Note 2	20	35		MHz
t _{PLH}	CLK	Q _H '	R _L = 2 kΩ, C _L = 15 pF, See Note 2		22	33	ns
t _{PHL}		Q _H			26	35	
t _{PHL}	CLR	Q _H			27	35	ns
t _{PLH}	CLK	Q _A thru Q _H	R _L = 665 Ω, C _L = 45 pF, See Note 2		16	25	ns
t _{PHL}		Q _A thru Q _H			22	33	
t _{PHL}	CLR	Q _A thru Q _H			22	35	ns
t _{PZH}	OE	Q _A thru Q _H			15	35	ns
t _{PZL}		Q _A thru Q _H			15	35	
t _{PHZ}	OE	Q _A thru Q _H	R _L = 665 Ω, C _L = 5 pF, See Note 2		15	25	ns
t _{PLZ}		Q _A thru Q _H			15	25	

¶ f_{max} = maximum clock frequency

t_{PZL} = output enable time to low level

t_{PLH} = propagation delay time, low to high level output

t_{PHZ} = output disable time from high level

t_{PHL} = propagation delay time, high to low level output

t_{PLZ} = output disable time from low level

t_{PZH} = output enable time to high level

NOTE 2. For testing f_{max}, all outputs are loaded simultaneously, each with C_L and R_L as specified for the propagation times. Load circuits and voltage waveforms are shown in Section 1.

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